

Notice of References Cited	Application/Control No. 10/713,790		Applicant(s)/Patent Under Reexamination PIER ET AL.	
	Examiner S. Devi, Ph.D.		Art Unit 1645	Page 1 of 1

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*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
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*	B	US-2,842,049	07-1958	DELANGRE JOHN P	430/199
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	L	US-			
	M	US-			

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	V	Du Yuguo English abstract of Chinese patent application 0113648, published 417/02
	W	Defaye et al. English abstract of FR 2,640,628.
	X	Yang et al. Tetrahedron Lett. 43: 7561-7563, October 2002

*A copy of this reference is not being furnished with this Office action. (See MPEP § 707.05(a).)
Dates in MM-YYYY format are publication dates. Classifications may be US or foreign.